

Substitute Form PTO-1449 (Modified)		U.S. Department of Commerce Patent and Trademark Office		Attorney's Docket No. 15682-017US1	107588921 Application No.
<b>Information Disclosure Statement</b> by Applicant (Use several sheets if necessary) (37 CFR §1.98(b))				Applicant Nobuo Imamura et al.	
		Filing Date January 31, 2006	Group Art Unit		

<b>U.S. Patent Documents</b>							
Examiner Initial	Desig. ID	Document Number	Publication Date	Patentee	Class	Subclass	Filing Date If Appropriate
	AA						
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<b>Foreign Patent Documents or Published Foreign Patent Applications</b>							
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation
							Yes No
/B.M./	AL	2002-096034	04/02/2002	Japan			X
	AM	06-190625	07/12/1994	Japan			X
	AN	09-085573	03/31/1997	Japan			X
	AO	05-16078	03/02/1993	Japan			X
	AP	51-122479	10/04/1976	Japan			X
	AQ	62-246455	10/27/1987	Japan			X
↓	AR	2-15244	01/30/1990	Japan			X
	AS	62-138546	09/01/1987	Japan			X

<b>Other Documents (include Author, Title, Date, and Place of Publication)</b>			
Examiner Initial	Desig. ID	Document	
	AT		
	AU		

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<b>Foreign Patent Documents or Published Foreign Patent Applications</b>							
Examiner Initial	Desig. ID	Document Number	Publication Date	Country or Patent Office	Class	Subclass	Translation Yes      No
/B.M./	AL	2002-361192	12/17/2002	Japan			X
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